

74AC251 • 74ACT251 8-Input Multiplexer with 3-STATE Output

General Description

The AC/ACT251 is a high-speed 8-input digital multiplexer. It provides, in one package, the ability to select one bit of data from up to eight sources. It can be used as universal function generator to generate any logic function of four variables. Both true and complementary outputs are provided.

Features

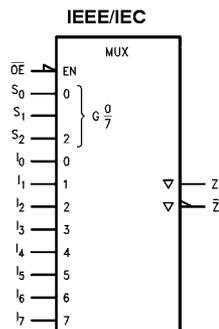
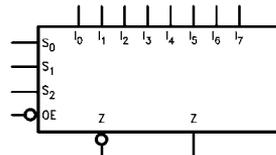
- I_{CC} reduced by 50%
- Multifunctional capability
- On-chip select logic decoding
- Inverting and noninverting 3-STATE outputs
- Outputs source/sink 24 mA
- ACT251 has TTL-compatible inputs

Ordering Code:

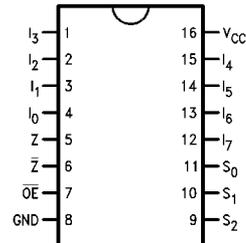
Order Number	Package Number	Package Description
74AC251SC	M16A	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow Body
74AC251SJ	M16D	16-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74AC251MTC	MTC16	16-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide
74AC251PC	N16E	16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide
74ACT251SC	M16A	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow Body
74ACT251MTC	MTC16	16-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide
74ACT251PC	N16E	16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide

Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering code.

Logic Symbols



Connection Diagram



Pin Descriptions

Pin Names	Description
S_0 – S_2	Select Inputs
\overline{OE}	3-STATE Output Enable Input
I_0 – I_7	Multiplexer Inputs
Z	3-STATE Multiplexer Output
\overline{Z}	Complementary 3-STATE Multiplexer Output

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Functional Description

This device is a logical implementation of a single-pole, 8-position switch with the switch position controlled by the state of three Select inputs, S₀, S₁, S₂. Both true and complementary outputs are provided. The Output Enable input (\overline{OE}) is active LOW. When it is activated, the logic function provided at the output is:

$$Z = \overline{OE} \cdot (I_0 \cdot \overline{S_0} \cdot \overline{S_1} \cdot \overline{S_2} + I_1 \cdot S_0 \cdot \overline{S_1} \cdot \overline{S_2} + I_2 \cdot \overline{S_0} \cdot S_1 \cdot \overline{S_2} + I_3 \cdot S_0 \cdot S_1 \cdot \overline{S_2} + I_4 \cdot \overline{S_0} \cdot \overline{S_1} \cdot S_2 + I_5 \cdot S_0 \cdot \overline{S_1} \cdot S_2 + I_6 \cdot \overline{S_0} \cdot S_1 \cdot S_2 + I_7 \cdot S_0 \cdot S_1 \cdot S_2)$$

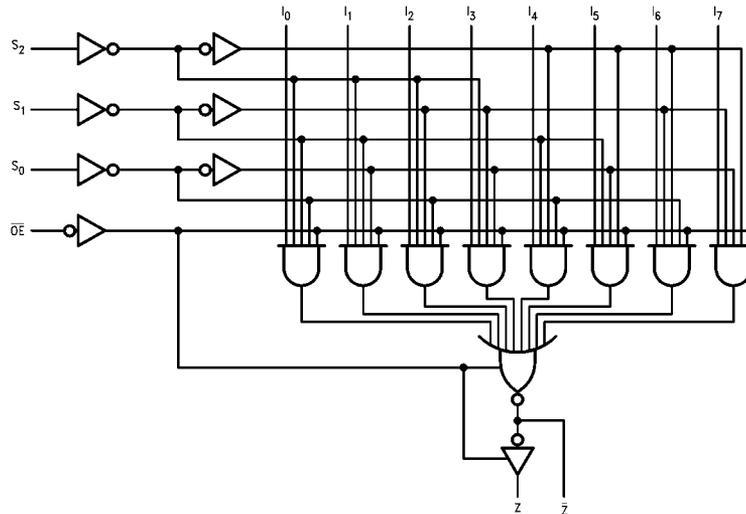
When the Output Enable is HIGH, both outputs are in the high impedance (High Z) state. This feature allows multiplexer expansion by tying the outputs of up to 128 devices together. When the outputs of the 3-STATE devices are tied together, all but one device must be in the high impedance state to avoid high currents that would exceed the maximum ratings. The Output Enable signals should be designed to ensure there is no overlap in the active-LOW portion of the enable voltages.

Truth Table

\overline{OE}	Inputs			Outputs	
	S ₂	S ₁	S ₀	\overline{Z}	Z
H	X	X	X	Z	Z
L	L	L	L	$\overline{I_0}$	I ₀
L	L	L	H	$\overline{I_1}$	I ₁
L	L	H	L	$\overline{I_2}$	I ₂
L	L	H	H	$\overline{I_3}$	I ₃
L	H	L	L	$\overline{I_4}$	I ₄
L	H	L	H	$\overline{I_5}$	I ₅
L	H	H	L	$\overline{I_6}$	I ₆
L	H	H	H	$\overline{I_7}$	I ₇

H = HIGH Voltage Level
 L = LOW Voltage Level
 X = Immaterial
 Z = High Impedance

Logic Diagram



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

Absolute Maximum Ratings (Note 1)

Supply Voltage (V_{CC})	-0.5V to +7.0V
DC Input Diode Current (I_{IK})	
$V_I = -0.5V$	-20 mA
$V_I = V_{CC} + 0.5V$	+20 mA
DC Input Voltage (V_I)	-0.5V to $V_{CC} + 0.5V$
DC Output Diode Current (I_{OK})	
$V_O = -0.5V$	-20 mA
$V_O = V_{CC} + 0.5V$	+20 mA
DC Output Voltage (V_O)	-0.5V to $V_{CC} + 0.5V$
DC Output Source	
or Sink Current (I_O)	±50 mA
DC V_{CC} or Ground Current	
per Output Pin (I_{CC} or I_{GND})	±50 mA
Storage Temperature (T_{STG})	-65°C to +150°C
Junction Temperature (T_J)	
PDIP	140°C

Recommended Operating Conditions

Supply Voltage (V_{CC})	
AC	2.0V to 6.0V
ACT	4.5V to 5.5V
Input Voltage (V_I)	0V to V_{CC}
Output Voltage (V_O)	0V to V_{CC}
Operating Temperature (T_A)	-40°C to +85°C
Minimum Input Edge Rate ($\Delta V/\Delta t$)	
AC Devices	
V_{IN} from 30% to 70% of V_{CC}	
V_{CC} @ 3.3V, 4.5V, 5.5V	125 mV/ns
ACT Devices	
V_{IN} from 0.8V to 2.0V	
V_{CC} @ 4.5V, 5.5V	125 mV/ns

Note 1: Absolute maximum ratings are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. Fairchild does not recommend operation of FACT™ circuits outside databook specifications.

DC Electrical Characteristics for AC

Symbol	Parameter	V_{CC} (V)	$T_A = +25^\circ\text{C}$		$T_A = -40^\circ\text{C to } +85^\circ\text{C}$		Units	Conditions
			Typ	Guaranteed Limits	Typ	Guaranteed Limits		
V_{IH}	Minimum HIGH Level Input Voltage	3.0	1.5	2.1	2.1	V	$V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$	
		4.5	2.25	3.15	3.15			
		5.5	2.75	3.85	3.85			
V_{IL}	Maximum LOW Level Input Voltage	3.0	1.5	0.9	0.9	V	$V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$	
		4.5	2.25	1.35	1.35			
		5.5	2.75	1.65	1.65			
V_{OH}	Minimum HIGH Level Output Voltage	3.0	2.99	2.9	2.9	V	$I_{OUT} = -50 \mu\text{A}$	
		4.5	4.49	4.4	4.4			
		5.5	5.49	5.4	5.4			
	3.0		2.56	2.46	V	$V_{IN} = V_{IL}$ or V_{IH} $I_{OH} = -12 \text{ mA}$ $I_{OH} = -24 \text{ mA}$ $I_{OH} = -24 \text{ mA}$ (Note 2)		
	4.5		3.86	3.76				
5.5		4.86	4.76					
V_{OL}	Maximum LOW Level Output Voltage	3.0	0.002	0.1	0.1	V	$I_{OUT} = 50 \mu\text{A}$	
		4.5	0.001	0.1	0.1			
		5.5	0.001	0.1	0.1			
	3.0		0.36	0.44	V	$V_{IN} = V_{IL}$ or V_{IH} $I_{OL} = 12 \text{ mA}$ $I_{OL} = 24 \text{ mA}$ $I_{OL} = 24 \text{ mA}$ (Note 2)		
4.5		0.36	0.44					
5.5		0.36	0.44					
I_{IN} (Note 4)	Maximum Input Leakage Current	5.5		±0.1	±1.0	μA	$V_I = V_{CC}, \text{ GND}$	
I_{OZ}	Maximum 3-STATE Current	5.5		±0.25	±2.5	μA	V_I (OE) = V_{IL}, V_{IH} $V_I = V_{CC}, V_{GND}$ $V_O = V_{CC}, \text{ GND}$	
I_{OLD}	Minimum Dynamic	5.5			75	mA	$V_{OLD} = 1.65V \text{ Max}$	
I_{OHD}	Output Current (Note 3)	5.5			-75	mA	$V_{OHD} = 3.85V \text{ Min}$	
I_{CC} (Note 4)	Maximum Quiescent Supply Current	5.5		4.0	40.0	μA	$V_{IN} = V_{CC}$ or GND	

Note 2: All outputs loaded; thresholds on input associated with output under test.

Note 3: Maximum test duration 2.0 ms, one output loaded at a time.

Note 4: I_{IN} and I_{CC} @ 3.0V are guaranteed to be less than or equal to the respective limit @ 5.5V V_{CC} .

DC Electrical Characteristics for ACT

Symbol	Parameter	V _{CC} (V)	T _A = +25°C		T _A = -40°C to +85°C		Units	Conditions
			Typ	Guaranteed Limits				
V _{IH}	Minimum HIGH Level Input Voltage	4.5	1.5	2.0	2.0	V	V _{OUT} = 0.1V or V _{CC} - 0.1V	
		5.5	1.5	2.0	2.0			
V _{IL}	Maximum LOW Level Input Voltage	4.5	1.5	0.8	0.8	V	V _{OUT} = 0.1V or V _{CC} - 0.1V	
		5.5	1.5	0.8	0.8			
V _{OH}	Minimum HIGH Level Output Voltage	4.5	4.49	4.4	4.4	V	I _{OUT} = -50 μA	
		5.5	5.49	5.4	5.4			
		4.5		3.86	3.76	V	V _{IN} = V _{IL} or V _{IH} I _{OH} = -24 mA I _{OH} = -24 mA (Note 5)	
		5.5		4.86	4.76			
V _{OL}	Maximum LOW Level Output Voltage	4.5	0.001	0.1	0.1	V	I _{OUT} = 50 μA	
		5.5	0.001	0.1	0.1			
		4.5		0.36	0.44	V	V _{IN} = V _{IL} or V _{IH} I _{OL} = 24 mA I _{OL} = 24 mA (Note 5)	
		5.5		0.36	0.44			
I _{IN}	Maximum Input Leakage Current	5.5		±0.1	±1.0	μA	V _I = V _{CC} , GND	
I _{OZ}	Maximum 3-STATE Current	5.5		±0.5	±5.0	μA	V _I = V _{IL} , V _{IH} V _O = V _{CC} , GND	
I _{CC1}	Maximum I _{CC} /Input	5.5	0.6		1.5	mA	V _I = V _{CC} - 2.1V	
I _{OLD}	Minimum Dynamic	5.5			75	mA	V _{OLD} = 1.65V Max	
I _{OHD}	Output Current (Note 6)	5.5			-75	mA	V _{OHD} = 3.85V Min	
I _{CC}	Maximum Quiescent Supply Current	5.5		4.0	40.0	μA	V _{IN} = V _{CC} or GND	

Note 5: All outputs loaded; thresholds on input associated with output under test.

Note 6: Maximum test duration 2.0 ms, one output loaded at a time.

AC Electrical Characteristics for AC

Symbol	Parameter	V _{CC} (V) (Note 7)	T _A = +25°C C _L = 50 pF			T _A = -40°C to +85°C C _L = 50 pF		Units
			Min	Typ	Max	Min	Max	
t _{PLH}	Propagation Delay S _n to Z or \bar{Z}	3.3	1.5	11.5	17.5	1.5	19.0	ns
		5.0	1.5	8.5	12.5	1.5	13.5	
t _{PHL}	Propagation Delay S _n to Z or \bar{Z}	3.3	1.5	11.0	17.5	1.5	19.0	ns
		5.0	1.5	8.0	12.5	1.5	13.5	
t _{PLH}	Propagation Delay I _n to Z or \bar{Z}	3.3	1.5	10.0	14.0	1.5	15.5	ns
		5.0	1.5	7.0	10.0	1.5	11.0	
t _{PHL}	Propagation Delay I _n to Z or \bar{Z}	3.3	1.5	9.0	14.0	1.5	15.5	ns
		5.0	1.5	6.5	10.0	1.5	11.0	
t _{PZH}	Output Enable Time \overline{OE} to Z or \bar{Z}	3.3	1.5	7.5	11.0	1.5	12.0	ns
		5.0	1.5	5.5	8.0	1.5	9.0	
t _{PZL}	Output Enable Time \overline{OE} to Z or \bar{Z}	3.3	1.5	7.5	11.0	1.5	12.0	ns
		5.0	1.5	5.5	8.0	1.5	9.0	
t _{PHZ}	Output Disable Time \overline{OE} to Z or \bar{Z}	3.3	1.5	8.5	11.5	1.5	13.0	ns
		5.0	1.5	7.0	9.5	1.5	10.0	
t _{PLZ}	Output Disable Time \overline{OE} to Z or \bar{Z}	3.3	1.5	7.0	11.0	1.5	12.0	ns
		5.0	1.5	5.5	8.0	1.5	8.5	

Note 7: Voltage Range 3.3 is 3.3V ± 0.3V.
Voltage Range 5.0 is 5.0V ± 0.5V

AC Electrical Characteristics for ACT

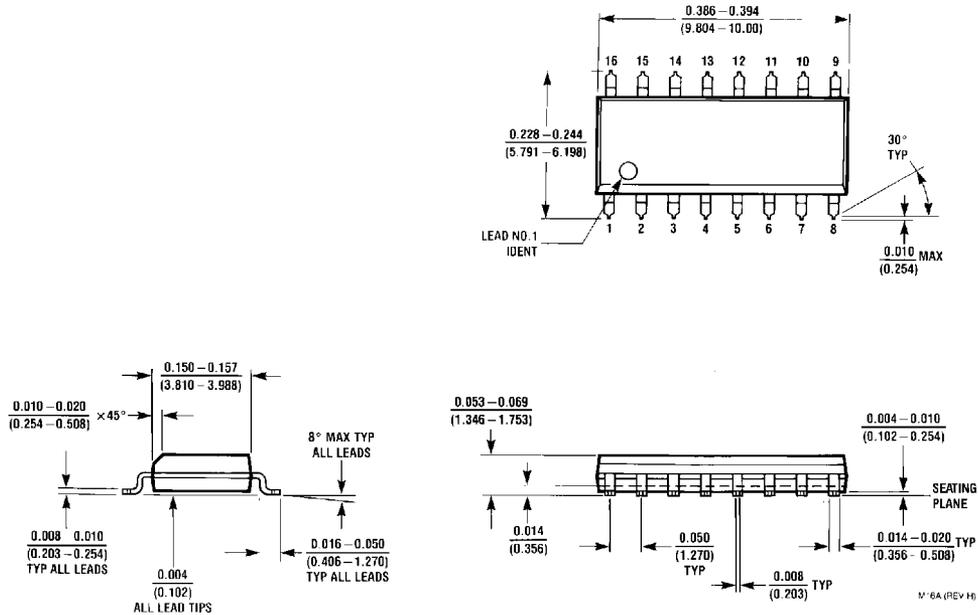
Symbol	Parameter	V _{CC} (V) (Note 8)	T _A = +25°C C _L = 50 pF			T _A = -40°C to +85°C C _L = 50 pF		Units
			Min	Typ	Max	Min	Max	
t _{PLH}	Propagation Delay S _n to Z or \bar{Z}	5.0	2.5	7.0	15.5	2.0	17.0	ns
t _{PHL}	Propagation Delay S _n to Z or \bar{Z}	5.0	2.5	7.5	16.5	2.5	18.5	ns
t _{PLH}	Propagation Delay I _n to Z or \bar{Z}	5.0	2.5	5.5	12.0	2.0	13.0	ns
t _{PHL}	Propagation Delay I _n to Z or \bar{Z}	5.0	2.5	6.5	12.5	2.5	14.0	ns
t _{PZH}	Output Enable Time \overline{OE} to Z or \bar{Z}	5.0	1.5	5.0	8.5	1.5	9.0	ns
t _{PZL}	Output Enable Time \overline{OE} to Z or \bar{Z}	5.0	1.5	4.5	8.5	1.5	9.5	ns
t _{PHZ}	Output Disable Time \overline{OE} to Z or \bar{Z}	5.0	2.0	6.0	12.0	2.0	13.0	ns
t _{PLZ}	Output Disable Time \overline{OE} to Z or \bar{Z}	5.0	1.5	4.5	8.5	1.5	9.0	ns

Note 8: Voltage Range 5.0 is 5.0V ±0.5V

Capacitance

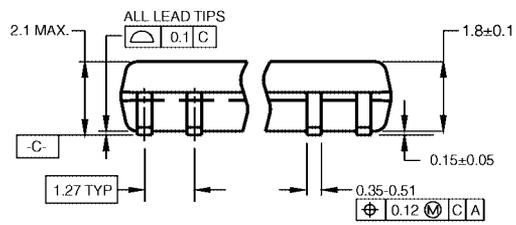
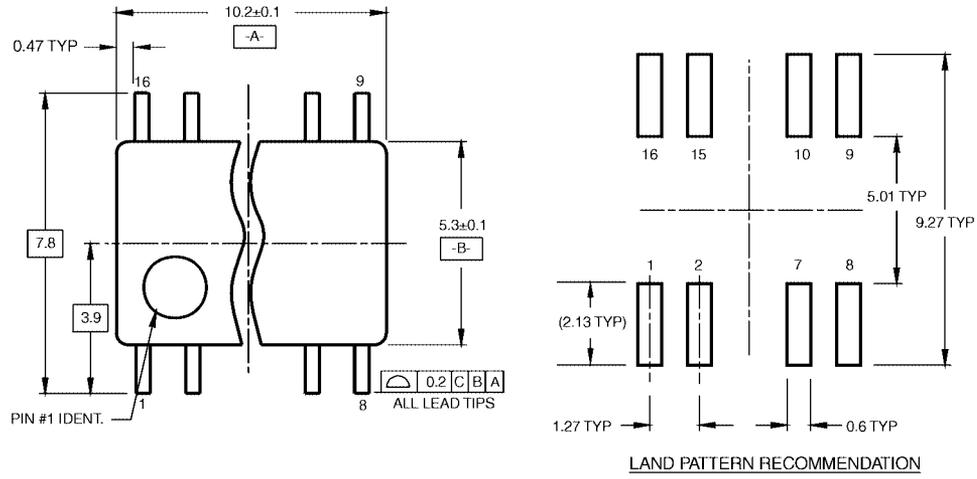
Symbol	Parameter	Typ	Units	Conditions
C _{IN}	Input Capacitance	4.5	pF	V _{CC} = OPEN
C _{PD}	Power Dissipation Capacitance	70.0	pF	V _{CC} = 5.0V

Physical Dimensions inches (millimeters) unless otherwise noted



**16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow Body
Package Number M16A**

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)

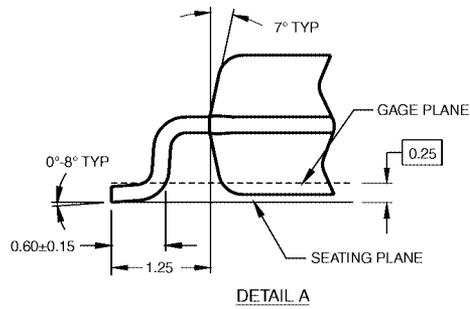
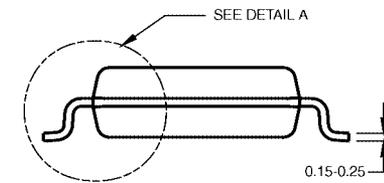


DIMENSIONS ARE IN MILLIMETERS

NOTES:

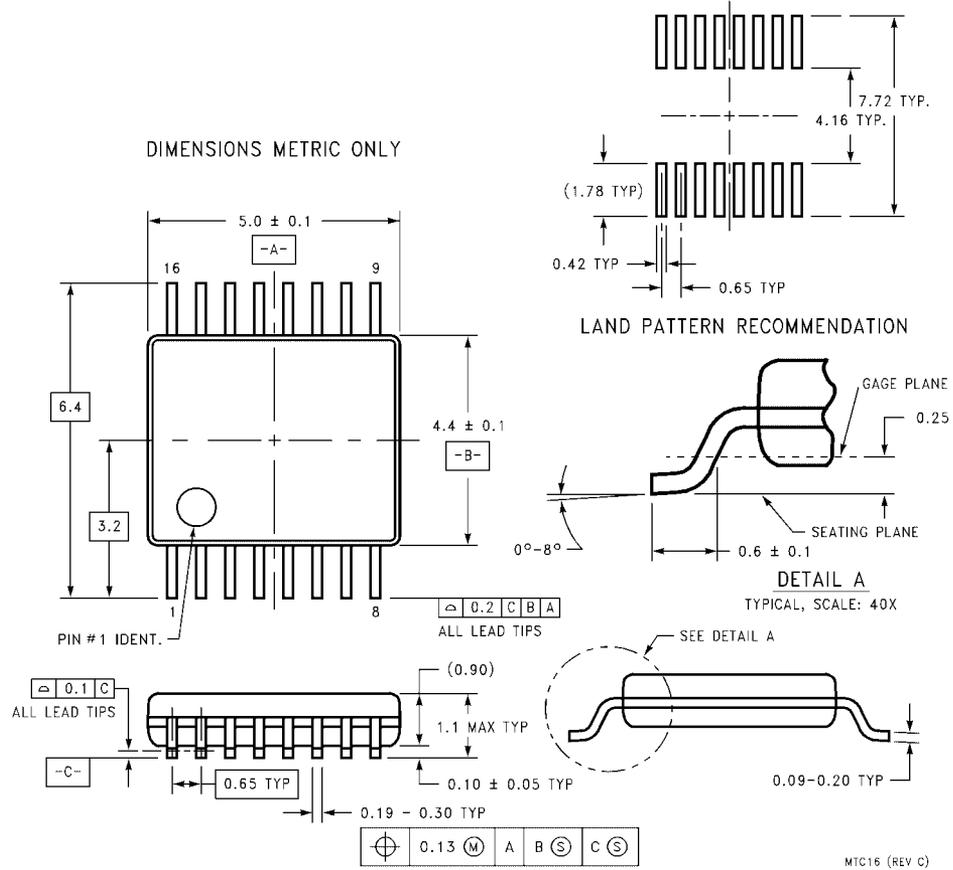
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- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.

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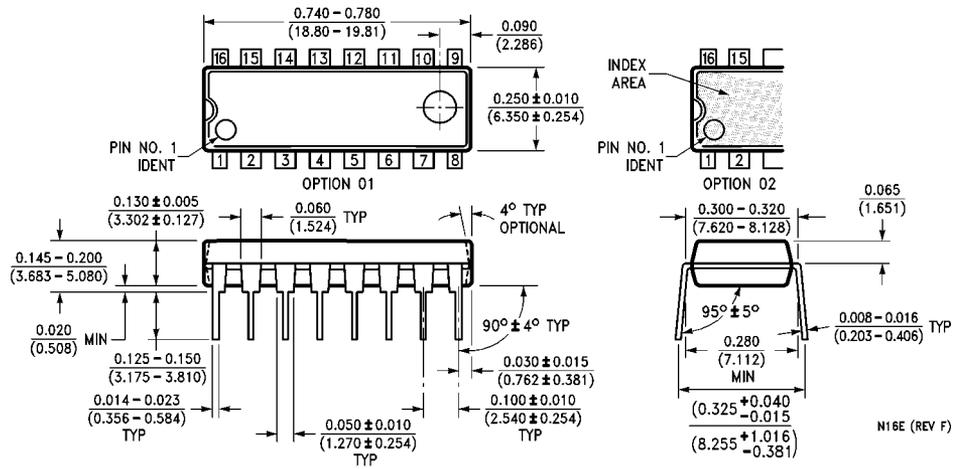
**16-Lead Small Outline Package (SOP), EIAJ Type II, 5.3mm Wide
Package Number M16D**

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



**16-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide
Package Number MTC16**

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide Package Number N16E

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